

Search Notes



Application/Control No.

10/539,532

Examiner

Kin-Chan Chen

Applicant(s)/Patent under Reexamination

VINET ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	692	6/19/2007	KCC
	694		
	700		
	706		
	710		
	714		
	401		
438	975	6/19/2007	KCC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East key words search USPAT, USPA-pub. EPO, JPO, Derwent IBM-TDB, inventor search	6/19/2007	KCC